

RoHS Compliant Product
A suffix of "-C" specifies halogen & lead-free

DESCRIPTION

S2N7002SW provides designers with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness. SOT-323 package is universally preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters.

FEATURES

- Halogen free products available
- ESD protected
- Low $R_{DS(on)}$

APPLICATIONS

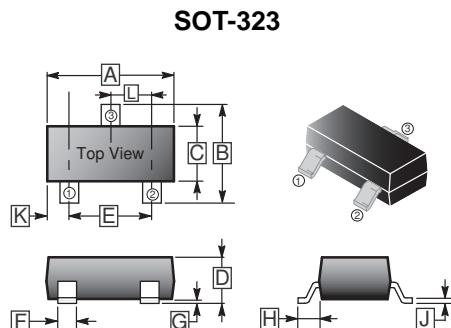
- Low side load switch
- Level shift circuits
- DC-DC converter
- Portable applications

MARKING

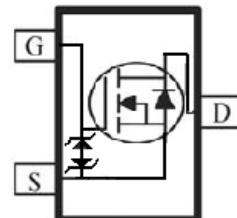
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PACKAGE INFORMATION

Package	MPQ	Leader Size
SOT-323	3K	7 inch



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	1.80	2.20	G	0.1 REF.	
B	1.80	2.55	H	0.525 REF.	
C	1.1	1.4	J	0.05 0.25	
D	0.80	1.15	K	0.8 TYP.	
E	1.20	2.00	L	0.65 TYP.	
F	0.15	0.50			



ABSOLUTE MAXIMUM RATINGS ($T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter		Symbol	Rating	Unit
Drain-Source Voltage		V_{DS}	60	V
Gate-Source Voltage		V_{GS}	± 20	V
Continuous Drain Current	Steady state, $T_A=25^\circ\text{C}$	I_D	0.32	A
	Steady state, $T_A=85^\circ\text{C}$		0.23	
	$t < 5\text{s}, T_A=25^\circ\text{C}$		0.38	
	$t < 5\text{s}, T_A=85^\circ\text{C}$		0.27	
Pulsed Drain Current@ $t_p=10\mu\text{s}$		I_{DM}	1.5	A
Source Current (Body diode)		I_S	0.3	A
Total Device Power Dissipation ¹	Steady state	P_D	300	mW
	$t < 5\text{s}$		420	
Thermal Resistance from Junction to Ambient ¹	Steady state	$R_{\theta JA}$	417	$^\circ\text{C} / \text{W}$
	$t < 5\text{s}$		300	
Gate-Source ESD Rating (HBM, method 3015)		ESD	2	kV
Lead Temperature for Soldering Purposes@ 1/8" from case for 10s		T_L	260	$^\circ\text{C}$
Operating Junction and Storage Temperature		T_J, T_{STG}	-55~150	$^\circ\text{C}$

ELECTRICAL CHARACTERISTICS ($T_J=25^\circ\text{C}$ unless otherwise specified)

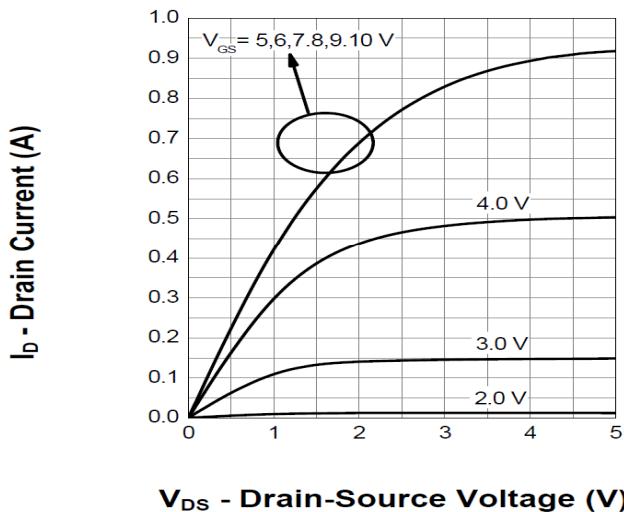
Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Condition
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	60	-	-	V	$V_{GS}=0$, $I_D=250\mu\text{A}$
Drain-Source Breakdown Voltage Temperature Coefficient	BV_{DSS} / T_J	-	71	-	mV / $^\circ\text{C}$	
Gate-Source Leakage Current	I_{GSS}	-	-	± 10	μA	$V_{DS}=0$, $V_{GS}= \pm 20\text{V}$
Drain-Source Leakage Current	I_{DSS}	-	-	1	μA	$V_{DS}=60\text{V}$, $V_{GS}=0$, $T_J=25^\circ\text{C}$
		-	-	500		$V_{DS}=60\text{V}$, $V_{GS}=0$, $T_J=125^\circ\text{C}$
		-	-	0.1		$V_{DS}=50\text{V}$, $V_{GS}=0$, $T_J=25^\circ\text{C}$
On Characteristics²						
Gate-Threshold Voltage	$V_{GS(\text{th})}$	1	-	2	V	$V_{DS}=V_{GS}$, $I_D=250\mu\text{A}$
Negative Threshold Voltage Temperature Coefficient	$V_{GS(\text{th})} / T_J$	-	4	-	mV / $^\circ\text{C}$	
Forward Transconductance	g_{fs}	0.08	-	-	S	$V_{DS}=5\text{V}$, $I_D=0.2\text{A}$
Static Drain-Source On-Resistance ³	$R_{DS(\text{ON})}$	-	-	2.8	Ω	$V_{GS}=10\text{V}$, $I_D=500\text{mA}$
		-	-	3.2		$V_{GS}=4.5\text{V}$, $I_D=200\text{mA}$
Dynamic Characteristics						
Input Capacitance	C_{iss}	-	21	-	pF	$V_{DS}=25\text{V}$ $V_{GS}=0$ $f=1\text{MHz}$
Output Capacitance	C_{oss}	-	12	-		
Reverse Transfer Capacitance	C_{rss}	-	0.35	-		
Total Gate Charge	$Q_{g(\text{TOT})}$	-	0.44	-	nC	$V_{DS}=10\text{V}$ $V_{GS}=4.5\text{V}$ $I_D=0.5\text{A}$
Gate-Source Charge	Q_{gs}	-	0.2	-		
Gate-Drain Charge	Q_{gd}	-	0.1	-		
Switching Characteristics						
Turn-on Delay Time	$T_{d(\text{on})}$	-	2.7	-	nS	$V_{DD}=30\text{V}$ $V_{GEN}=10\text{V}$ $R_G=25\Omega$ $R_L=60\Omega$ $I_D=0.5\text{A}$
Rise Time	T_r	-	2.5	-		
Turn-off Delay Time	$T_{d(\text{off})}$	-	13	-		
Fall Time	T_f	-	8	-		
Drain-Source Diode Characteristics						
Diode Forward Voltage	V_{SD}	-	0.85	-	V	$I_s=0.5\text{A}$, $V_{GS}=0$

Notes:

- FR-4 board is $1 \times 0.75 \times 0.062$ inch.
- Pulse Test: Pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.

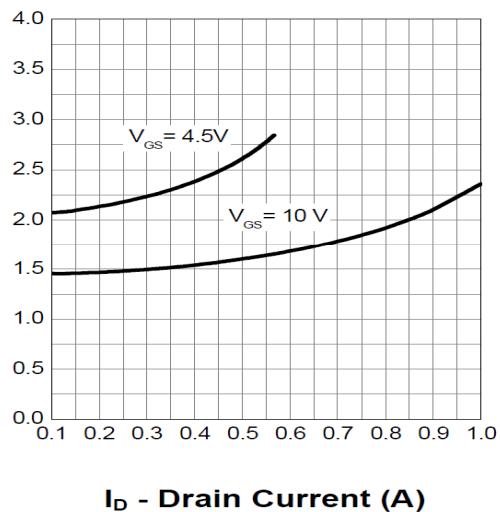
CHARACTERISTIC CURVES

Output Characteristics



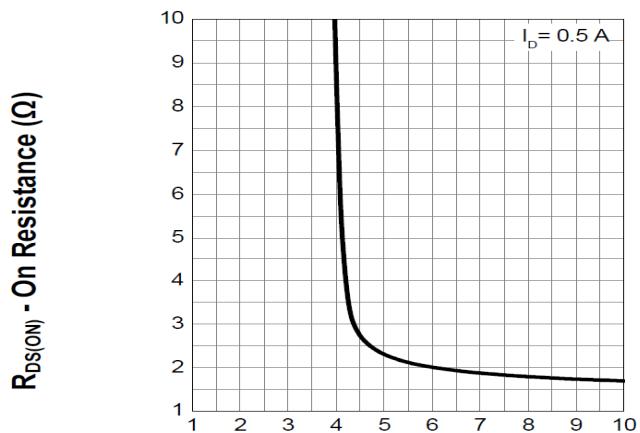
V_{DS} - Drain-Source Voltage (V)

Drain-Source On Resistance



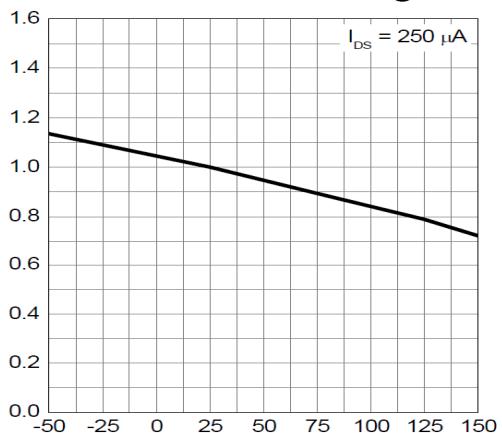
I_D - Drain Current (A)

Transfer Characteristics



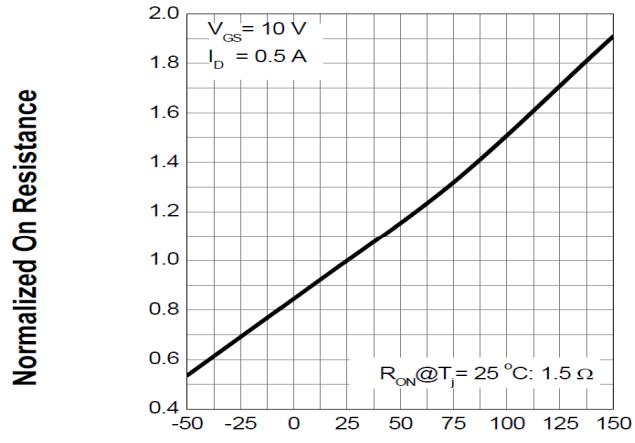
V_{GS} - Gate-Source Voltage (V)

Gate Threshold Voltage



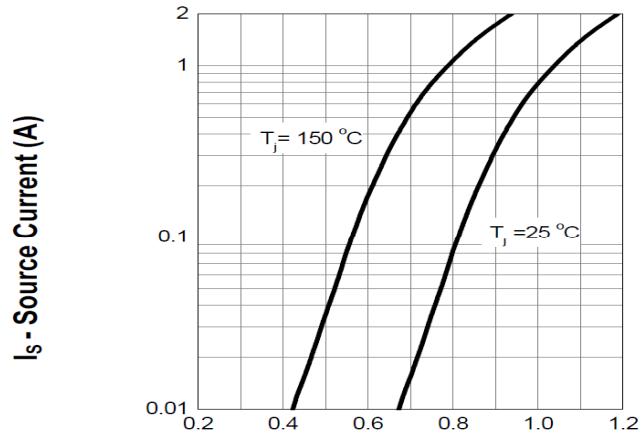
T_j - Junction Temperature (°C)

Drain-Source On Resistance



T_j - Junction Temperature (°C)

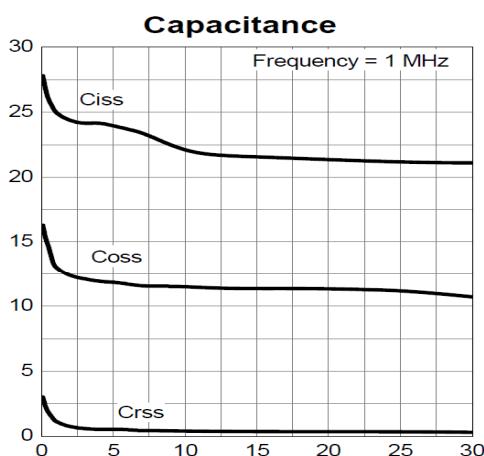
Source-Drain Diode Forward



V_{SD} - Source-Drain Voltage (V)

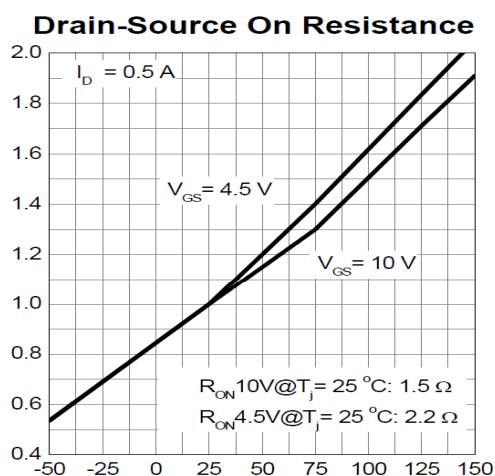
CHARACTERISTIC CURVES

C - Capacitance (pF)



V_{DS} - Drain-Source Voltage (V)

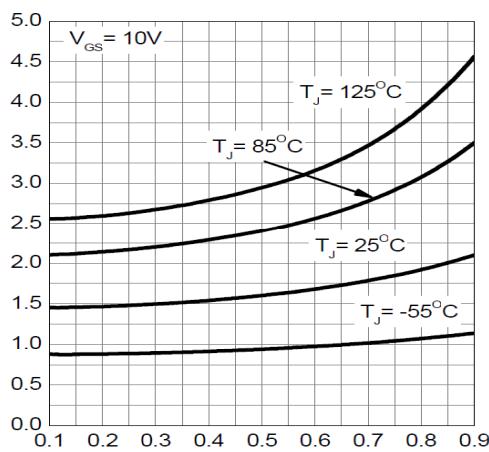
Normalized On Resistance



T_j - Junction Temperature (°C)

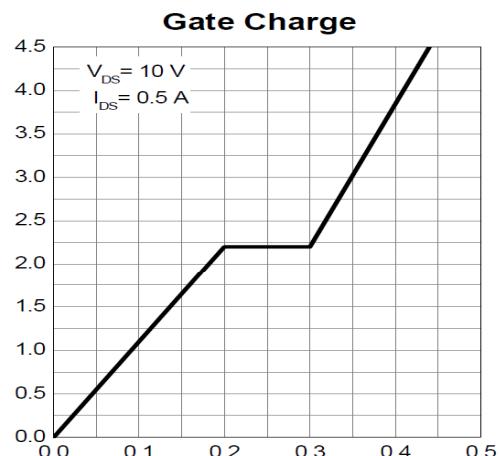
Drain-Source On Resistance

R_{DS(ON)} - On Resistance (Ω)



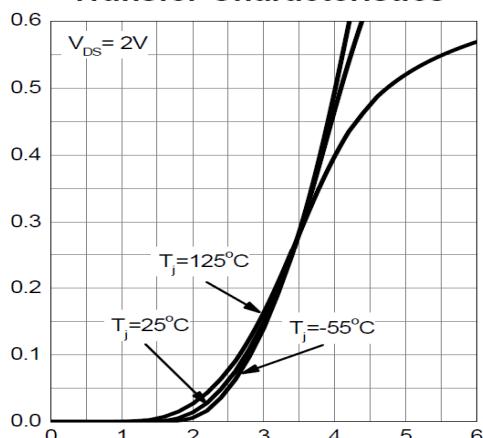
I_D - Drain Current (A)

V_{GS} - Gate-Source Voltage (V)



Q_G - Gate Charge (nC)

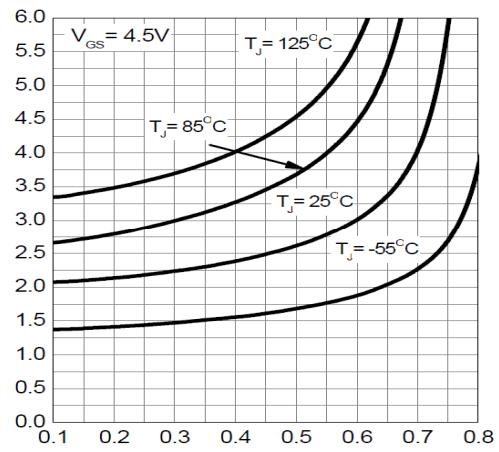
Transfer Characteristics



V_{GS} - Gate-Source Voltage (V)

Drain-Source On Resistance

R_{DS(ON)} - On Resistance (Ω)



I_D - Drain Current (A)